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| Search Notes  | Application/Control No. 10647540 | Applicant(s)/Patent Under Reexamination NAPHADE ET AL. |
| | Examiner ALEX LIEW | Art Unit 2624 |

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| SEARCHED | | | |
| Class | Subclass | Date | Examiner |
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| SEARCH NOTES | | |
| Search Notes | Date | Examiner |
| 382 limited to text search | 1/31/09 | AL |
| 382/117,181-231 limited to text search | 7/27/09 | AL |

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| INTERFERENCE SEARCH | | | |
| Class | Subclass | Date | Examiner |
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